

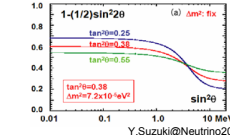
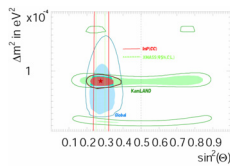
Development of InP detector for solar pp/7Be neutrino measurement

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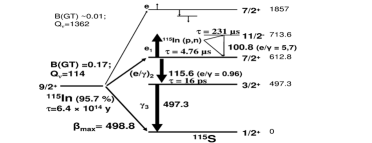
1. Introduction

- ◆ Purpose : Precise measurement of ν oscillation mixing angle θ_{12}
- ◆ Status of determination for ν oscillation parameter

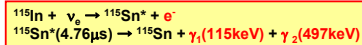


◆ Technique of low energy solar neutrino detection

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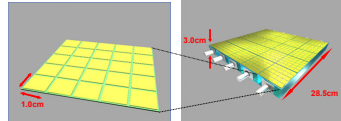
- Advantage
 - direct counting
 - sensitive to low energy ν_e ($E_e \geq 125$ keV)
 - measuring the energy ($E_e = E_\nu - 125$ keV)
 - Triple fold coincidence to extract neutrino signal from huge BG ($e_1 + \gamma_2 + \gamma_3$)
- Disadvantage
 - natural β -decay of ^{115}In ($\tau_{1/2} = 6.4 \times 10^{14}$ yr)
 - Possible BG due to correlated accidental coincidence by Bremsstrahlung



◆ Possible detector with 4tons of ^{115}In assuming 5 years ope.

- Number of expected events assuming no ν oscillation $\rightarrow 1885$
- Number of expected event assuming LMA solution with $E_e \geq 100$ keV $\rightarrow 720$

Statistical and theoretical error in total $\rightarrow -3.9\%$ $\Rightarrow \theta_{12} = 29^\circ - 34^\circ$

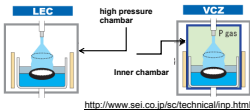


- Hybrid structure of InP and solid scintillator
 - InP detector module 10mmX10mmX0.2mm cell
 - Solid scintillator surrounding InP detector to detect γ s
- 4tons of ^{115}In detector for solar ν experiment
 - InP : 5.1tons (2.1X10⁶ modules)
 - solid scintillator (ex. CsI) : 934tons
 - total size : 6.3m X 6.3m X 5.3m

2. Semi-Insulating(SI) InP semi-conductor

◆ InP crystal growth method

● VCZ (Vapor Pressure Controlled Czochralski)



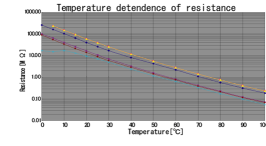
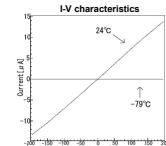
• Product : Sumitomo Electric Industries, Ltd.

• Process

In inner chamber controlled by steam pressure of As or P, covering material melt by B₂O₃ like LEC method and pulling up single crystal growth from it. Because of crystal growth in low temperature gradient, transition density can reduce.

● Characteristic table

EPD	~5,000cm ²
Conduct	Semi-insulation
Dopant	InP(Fe)
Resistivity	(4.9~5.2) × 10 ⁷ Ω cm
Mobility	(2.8~2.7) × 10 ³ Ω cm
Thickness	456~459μm
Diameter	50.00mm
Orientation	(100) ± 0.03°



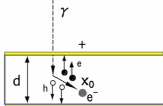
$I [A] \propto T^{2.3} \exp(-E_g/2k_B T)$
 E_g : band gap (1.29eV)
 k_B : Boltzmann constant
 T : element temperature

Dark current could be reduced by lowering temperature

● Characteristic of SI InP semi-conductor is both target and detector

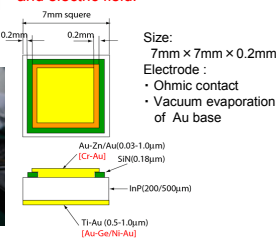
3. Test Module with the SI InP

◆ Detection of radiation with SI InP solid state detector



drift length : $L_d = \tau v = \mu E_0 d$ τ : carrier lifetime [s]
 e/h creation energy : ϵ_{eh}
 charge $Q_{obs}[C] = (e/h) \epsilon_{eh} X_e$
 $L_d \approx \infty$ $Q_{obs}[C] = \int_0^d (dE/dx) / \epsilon_{eh} e^{-x/L_d} dx \times e$

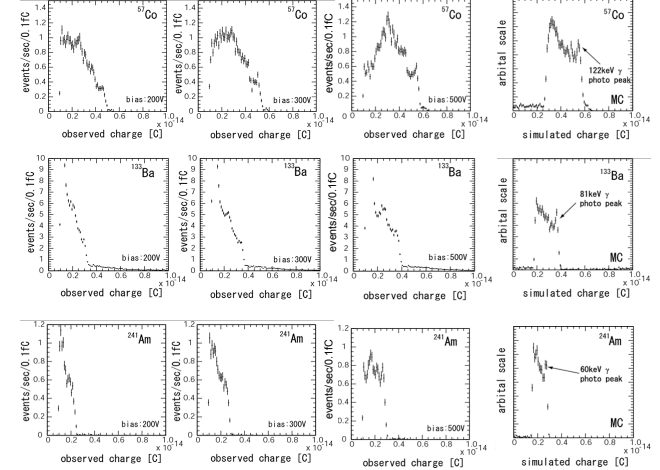
● InP detector with cooling dewar



Schematic view of InP detector

4. Spectrum analysis

◆ Response from ^{57}Co , ^{133}Ba and ^{241}Am



γ spectrum obtained by InP detector

- Photo electric peak for 81keV (^{133}Ba), 122keV (^{57}Co) and 60keV (^{241}Am) were observed,
- However, two peaks were found,
- Higher peak corresponds to photo electric peak with charge collection efficiency (CCE) 100%.
- Average energy of electron/hole pair production is obtained by 3.5eV
- Lower peak obtained by carrier drift is equivalent to CCE 56% (^{57}Co) and 72% (^{133}Ba), respectively
- Intrinsic energy resolution $\sigma = 5\%$ @ 122keV

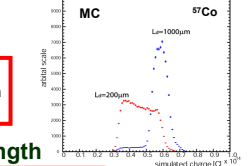
Spectral analysis with MC

- Assuming charge collection due to both depletion layer formed at the ohmic contact between electrode and InP and drift of carrier in remaining region
- Input parameter : thickness of depletion layer : 30μm
- Drift length: 250μm, e/h production energy : 3.5eV
- MC reproduces spectral shape of data well

Carrier drift length L_d should be longer

Low CCE signal improved by increasing carrier drift length

Assuming $L_d \sim 1000\mu\text{m}$, photo electric peak will be single peak with good energy resolution

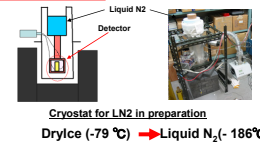
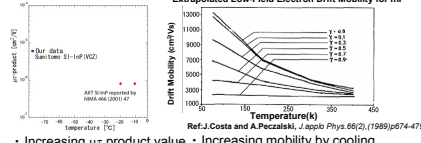


◆ How to increase the carrier drift length

1. Increasing mobility (μ)

Temperature \rightarrow lower

● $\mu\tau$ product value



Direct measurement of mobility using Hall Effect will be done by Semiconductor Research Institute.

2. Higher bias voltage (V_0)

Change electrode material (Au \rightarrow Pd or Ag)

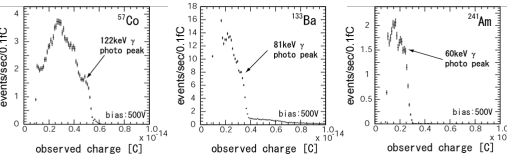
- Avoid electric noise due to dark current
- Schottky barrier height: 0.37eV(Au) / 0.41eV(Pd) / 0.54eV(Ag) Ref: J.Phys.III 1(1991) 749-758

5. Prototype detector

◆ proto-type module



● Response for γ -rays



• No. of Events have been increased by 3.1 times as compared with 2.8 times larger electrode area (^{57}Co).

• Effective area spread.

• Proto-type module has same performance as test module.

◆ Prototype detector for solar neutrino experiment

- proto-type detector consists of 4 modules
- Measurement of ^{115}In β -decay spectrum and bremsstrahlung in Kamioka mine
 - estimate effect of accidental coincidence due to backgrounds.
 - establish counting methods.
 - Kyoudou-riyou program of ICRR, Univ. of Tokyo
 - experiment will start at the end of this year or early of next year

